

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KAMO ET AL.	
		Examiner Dah-Wei D. Yuan	Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,506,513	01-2003	Yonetsu et al.	429/34
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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